AMENDMENTS TO THE CLAIMS

This listing of claims replaces all prior versions, and listings, of claims in the application:

(Currently Amended) A measurement method for measuring a physical value, 1 1.-2 comprising 3 during [[a]] one clock cycle: forming an input signal, a reference signal and an offset signal, the input signal including a parasitic value and a useful measurement 4 5 value, the signals being respectively associated with an input element, a reference 6 element and a parasitic element, all these elements being coupled [[and]] in a 7 same current or voltage path, thus having a common driving signal of [[the]] a 8 same value, the parasitic value depending on the common driving signal, and 9 deriving a relationship between the input signal, from which the parasitic value has been 10 cancelled out, and the reference signal, and from this relationship, determining a value relating to the physical value. 11 1 2.-(Original) A measurement method according to claim 1, wherein the input signal is a 2 first voltage. 1 3.-(Original) A measurement method according to claim 2, wherein the first voltage is 2 obtained from a direct voltage drop over the sensing element. (Original) A measurement method according to claim 1, wherein the reference signal is a 1 4.-2 second voltage. 1 5.-(Original) A measurement method according to claim 2, wherein the reference signal is a 2 second voltage. 1 6.-(Original) A measurement method according to claim 4, wherein the second voltage is 2 obtained from a direct voltage drop over the reference element.

- 1 7.- (Original) A measurement method according to claim 1, wherein the reference element is a reference resistor.
- 1 8.- (Original) A measurement method according to claim 1, wherein the offset signal is a third voltage.
- 1 9.- (Original) A measurement method according to claim 2, wherein the offset signal is a third voltage.
- 1 10.- (Original) A measurement method according to claim 4, wherein the offset signal is a third voltage.
- 1 11.- (Original) A measurement method according to claim 8, wherein the third voltage is obtained from a direct voltage drop over the parasitic element.
- 1 12.- (Original) A measurement method according to claim 1, wherein the physical value includes any of temperature, a pressure, a light intensity, a position.

1	13	(Currently Amended) A measurement system for indirect measurement of a physical
2		value, comprising
3		an analog-to-digital converter with at least a first, a second and a third port, each of the at
4		least three ports being suitable for receiving an input signal from an element, the
5		analog-to-digital converter being suitable for evaluating the physical value in one
6		measurement cycle,
7		a sensing element having a pre-defined characteristic parameter related to the physical
8		value to be measured, being coupled to the first port for applying an input signal
9		to said first port,
10		a reference element being coupled to the second port for applying a reference signal to
11		the second port,
12		an element corresponding to a parasitic value of the sensing element, being coupled to the
13		third port for applying a parasitic value of the sensing element to the third port,
14		the element, being coupled with the sensing element and the reference element
15		[[and]] being coupled in a same current or voltage path, thus having a common
16		driving signal of [[the]] a same value,
17		means for deriving a relationship between the input signal, from which the parasitic value
18		of sensing element has been cancelled out, and the reference signal, and
19		means for deriving, from the relationship, a value relating to the physical value.
1	14	(Original) A measurement system according to claim 13, wherein the reference element
2		is coupled in series with the sensing element.
1	15	(Original) A measurement system according to claim 13, wherein the element
2		corresponding to a parasitic value of the sensing element is coupled in series with the
3		sensing element.
1	16	(Original) A measurement system according to claim 14, wherein the element
2		corresponding to a parasitic value of the sensing element is coupled in series with the
3		sensing element.

- 1 17.- (Original) A measurement system according to claim 13, wherein the reference element comprises a reference resistor.
- 1 18.- (Original) A measurement system according to claim 13, wherein the physical value is 2 any of a temperature, a pressure, a light intensity, a position.
- 1 19.- (New) A measurement method according to claim 1, wherein the input signal, the
 2 reference signal and the offset signal are fed to a digital-to-analog converter with at least
 3 a first, a second and a third port.